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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

T. MORIMOTO et al

Serial No. 09/626,106

Group Art Unit: 2881

Filed: July 26, 2000

Examiner: Bernard E. Souw

For: SCANNING PROBE MICROSCOPE AND METHOD OF MEASUREMENT

AMENDMENT

Commissioner of Patents Washington, D.C. 20231

sir:

In response to the Office Action mailed June 19, 2002, please amend the above application as follows. A petition and fee for a three-month Extension of Time also accompanies this response.

IN THE SPECIFICATION

Pages 9 and 10, the paragraph bridging these pages from page 9, line 20 to page 10, line 11, replace the paragraph with:

--Further, since the probe is separated (or moved backward) at locations other than the sampling positions, it is necessary to suspend the control by the servo control system at the time of separating. The reason is that even if a backward signal is given to the actuator to control the height of the probe, if the above servo control is being